

IEEE HOME | SEARCH IEEE | SHOP | WEB ACCOUNT | CONTACT IEEE


[Membership](#) | [Publications/Services](#) | [Standards](#) | [Conferences](#) | [Careers/Jobs](#)
IEEE Xplore
RELEASE 1.0

 Welcome
 United States Patent and Trademark Office


» Se

[Help](#) | [FAQ](#) | [Terms](#) | [IEEE Peer Review](#)
[Quick Links](#)
Welcome to IEEE Xplore

- ☐ Home
- ☐ What Can I Access?
- ☐ Log-out

Tables of Contents

- ☐ Journals & Magazines
- ☐ Conference Proceedings
- ☐ Standards

Search

- ☐ By Author
- ☐ Basic
- ☐ Advanced

Member Services

- ☐ Join IEEE
- ☐ Establish IEEE Web Account
- ☐ Access the IEEE Member Digital Library

 Your search matched **3** documents.

 A maximum of **500** results are displayed, **15** to a page, sorted by **Relevance Descending** order.

Results Key:
JNL = Journal or Magazine **CNF** = Conference **STD** = Standard

1 3D reconstruction of environments for virtual collaboration

Bajcsy, R.; Enciso, R.; Kamberova, G.; Nocera, L.; Sara, R.;
 Applications of Computer Vision, 1998. WACV '98. Proceedings., Fourth IEEE Workshop on , 19-21 Oct. 1998
 Pages:160 - 167

[\[Abstract\]](#) [\[PDF Full-Text \(1172KB\)\]](#) IEEE CNF

2 Three-dimensional reconstruction from a set of video cameras of environments for virtual collaboration

Bajcsy, R.; Kamberova, G.; Enciso, R.; Nocera, L.; Fuchs, H.; Welch, G.; Sara;
 Computer Graphics, Image Processing, and Vision, 1998. Proceedings. SIBGR '98. International Symposium on , 20-23 Oct. 1998
 Pages:36

[\[Abstract\]](#) [\[PDF Full-Text \(8KB\)\]](#) IEEE CNF

3 A simulation-based validation of some improvements in automatic stereo-radargrammetry

Nocera, L.; Dupont, S.; Berthod, M.;
 Geoscience and Remote Sensing Symposium, 1996. IGARSS '96. 'Remote Sensing for a Sustainable Future.', International , Volume: 1 , 27-31 May 1996
 Pages:25 - 27 vol.1

[\[Abstract\]](#) [\[PDF Full-Text \(364KB\)\]](#) IEEE CNF

[Home](#) | [Log-out](#) | [Journals](#) | [Conference Proceedings](#) | [Standards](#) | [Search by Author](#) | [Basic Search](#) | [Advanced Search](#) | [Join IEEE](#) | [Web Account](#) | [New this week](#) | [OPAC Linking Information](#) | [Your Feedback](#) | [Technical Support](#) | [Email Alerting](#) | [No Robots Please](#) | [Release Notes](#) | [IEEE Online Publications](#) | [Help](#) | [FAQ](#) | [Terms](#) | [Back to Top](#)

Copyright © 2004 IEEE — All rights reserved